## GENERAL DESCRIPTION

New generation, high-voltage, high-speed switching npn transistor in a plastic full-pack envelope intended for use in horizontal deflection circuits of HDTV receivers and pc monitors.

## QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
| :--- | :--- | :--- | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CESM }}$ | Collector-emitter voltage peak value | $\mathrm{V}_{\mathrm{BE}}=0 \mathrm{~V}$ | - | 1500 | V |
| $\mathrm{~V}_{\text {CEO }}$ | Collector-emitter voltage (open base) |  | - | 800 | V |
| $\mathrm{I}_{\mathrm{C}}$ | Collector current (DC) |  | - | 11 | A |
| $\mathrm{I}_{\mathrm{CM}}$ | Collector current peak value |  | - | 29 | A |
| $\mathrm{P}_{\text {tot }}$ | Total power dissipation | $\mathrm{I}_{\text {hs }} \leq 25{ }^{\circ} \mathrm{C}$ | - | 45 | W |
| $\mathrm{~V}_{\text {CEsat }}$ | Collector-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=5.5 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=1.1 \mathrm{~A}$ | 5.0 | V |  |
| $\mathrm{I}_{\text {Csat }}$ | Collector saturation current | $\mathrm{f}_{\mathrm{f}}=64 \mathrm{kHz}$ | 5.5 | - | A |
| $\mathrm{t}_{\mathrm{f}}$ | Fall time | $\mathrm{I}_{\text {Csat }}=5.5 \mathrm{~A} ; \mathrm{f}=64 \mathrm{kHz}$ | 0.15 | 0.3 | $\mu \mathrm{~S}$ |

PINNING - SOT199

| PIN | DESCRIPTION |
| :---: | :--- |
| 1 | base |
| 2 | collector |
| 3 | emitter |
| case | isolated |

## PIN CONFIGURATION



SYMBOL


## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum Rating System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CESM }}$ | Collector-emitter voltage pe | $\mathrm{V}_{\text {BE }}=0 \mathrm{~V}$ |  | 1500 | V |
| $\mathrm{V}_{\text {CEO }}$ | Collector-emitter voltage (open base) |  |  | 800 | V |
| $1{ }_{\text {c }}$ | Collector current (DC) |  |  | 11 | A |
| см | Collector current peak value |  |  | 29 | A |
| $\mathrm{I}_{\mathrm{B}}$ | Base current (DC) |  |  | 7 | A |
| $\mathrm{I}_{\text {BM }}$ | Base current peak value |  |  | 10 | A |
| $\stackrel{-1}{\text { B(AV) }}$ | Reverse base current Reverse base current peak value ${ }^{1}$ | average over any 20 ms period |  | 175 7 | $\mathrm{mA}_{\mathrm{A}}$ |
| $\mathrm{P}_{\text {fot }}^{\text {BM }}$ | Total power dissipation | $\mathrm{T}_{\text {hs }} \leq 25^{\circ} \mathrm{C}$ | - | 45 | W |
| $\mathrm{T}_{\text {stg }}^{\text {tot }}$ | Storage temperature |  | -55 | 150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{i}}$ | Junction temperature |  |  | 150 | C |

## THERMAL RESISTANCES

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
| :--- | :--- | :--- | :---: | :---: | :---: |
| $\mathrm{R}_{\mathrm{th} j-\mathrm{hs}}$ | Junction to heatsink | with heatsink compound | - | 2.8 | K/W |
| $\mathrm{R}_{\mathrm{th} j-\mathrm{a}}$ | Junction to ambient | in free air | 35 | - | $\mathrm{K} / \mathrm{W}$ |

[^0]
## ISOLATION LIMITING VALUE \& CHARACTERISTIC

$\mathrm{T}_{\text {hs }}=25^{\circ} \mathrm{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| :--- | :--- | :--- | :---: | :---: | :---: | :---: |
| V $_{\text {isol }}$ | Repetitive peak voltage from all <br> three terminals to external <br> heatsink | R.H. $\leq 65 \%$; clean and dustfree | - |  | 2500 | V |
| $\mathrm{C}_{\text {isol }}$ | Capacitance from T2 to external <br> heatsink | $\mathrm{f}=1 \mathrm{MHz}$ | - | 22 | - | pF |

## STATIC CHARACTERISTICS

$\mathrm{T}_{\mathrm{hs}}=25{ }^{\circ} \mathrm{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {CES }}$ | Collector cut-off current ${ }^{2}$ | $\mathrm{V}_{\text {BE }}=0 \mathrm{~V} ; \mathrm{V}_{\text {CE }}=\mathrm{V}_{\text {CESMmax }}$ |  |  | 1.0 | mA |
| $\mathrm{I}_{\text {ces }}$ |  | $\mathrm{V}_{\mathrm{BE}}^{\mathrm{BE}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{CE}}=\mathrm{V}_{\mathrm{CESMmax}} \text {; }$ |  |  | 2.0 | mA |
|  | Emitter cut-off current | , ${ }^{\text {d }}=125.5 \mathrm{~V} ; \mathrm{I}_{\mathrm{C}}=0 \mathrm{~A}$ |  |  | 1.0 | mA |
| $\mathrm{BV}_{\text {Ebo }}$ | Emitter-base breakdown voltage | $\mathrm{I}_{\mathrm{B}}=1 \mathrm{~mA}$ | 7.5 | 13.5 | - | V |
| $\mathrm{V}_{\text {CEOSust }}$ | Collector-emitter sustaining voltage | $\mathrm{I}_{\mathrm{B}}=0 \mathrm{~A} ; \mathrm{I}_{\mathrm{C}}=100 \mathrm{~mA}$; | 800 |  | - | V |
| $\mathrm{V}_{\text {CEsat }}$ | Collector-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=5.5 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=1.1 \mathrm{~A}$ | - | - | 5.0 | V |
| $\mathrm{V}_{\text {BEssat }}^{\text {CEsat }}$ | Base-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=5.5 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=1.1 \mathrm{~A}$ |  | - | 1.0 | V |
| $\mathrm{h}_{\text {FE }}$ | DC current gain | $\mathrm{I}_{\mathrm{C}}=1 \mathrm{~A} ; \mathrm{V}_{\mathrm{CE}}=5 \mathrm{~V}$ |  | 14 |  |  |
| $\mathrm{h}_{\text {FE }}$ |  | $\mathrm{I}_{\mathrm{C}}=5.5 \mathrm{~A} ; \mathrm{V}_{\text {CE }}=5 \mathrm{~V}$ | 5 | 8 | 10.3 |  |

## DYNAMIC CHARACTERISTICS

## $\mathrm{T}_{\text {hs }}=25^{\circ} \mathrm{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Switching times ( 64 kHz line deflection circuit) | $\begin{aligned} & \mathrm{I}_{\text {sata }}=5.5 \mathrm{~A} ; \mathrm{L}_{\mathrm{C}}=200 \mu \mathrm{H} ; \mathrm{C}_{\text {fo }}=4 \mathrm{nF} ; \\ & \mathrm{V}_{\mathrm{cc}} 145 \mathrm{~V} ; \mathrm{I}_{\text {Bend }}=0.56 \mathrm{~A} ; \end{aligned}$ |  |  |  |
| $\mathrm{t}_{\text {t }}$ | Turn-off storage time Turn-off fall time |  | $\begin{aligned} & 1.5 \\ & 0.15 \end{aligned}$ | $\begin{aligned} & 2.0 \\ & 0.3 \end{aligned}$ | $\underset{\mathrm{us}}{\mu \mathrm{~s}}$ |



Fig.1. Switching times waveforms.


Fig.2. Switching times definitions.

[^1]
## Silicon Diffused Power Transistor



Fig.3. Switching times test circuit.


Fig.4. High and low DC current gain. $h_{F E}=f\left(I_{C}\right)$ $V_{C E}=1 \mathrm{~V}$


Fig.5. High and low $D C$ current gain. $h_{F E}=f\left(I_{C}\right)$ $V_{C E}=5 \mathrm{~V}$


Fig.6. Typical collector-emitter saturation voltage. $V_{C E} s a t=f\left(I_{C}\right) ;$ parameter $I_{d} I_{B}$


Fig.7. Typical base-emitter saturation voltage.
$V_{B E}$ Sat $=f\left(I_{B}\right)$; parameter $I_{C}$


Fig.8. Typical losses.
$P_{\text {TOT }}=f\left(I_{B}\right) ; I_{C}=5.5 A ; f=64 \mathrm{kHz}$

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Fig.9. Typical collector storage and fall time. $t s=f\left(I_{B}\right) ; t f=f\left(I_{B}\right) ; I_{C}=5.5 \mathrm{~A} ; T_{j}=85^{\circ} \mathrm{C} ; f=64 \mathrm{kHz}$


Fig.10. Normalised power dissipation.
$P D \%=100 \cdot P_{D} / P_{D 25^{\circ} \mathrm{C}}=f\left(T_{m b}\right)$


Fig.11. Transient thermal impedance.
$Z_{t h i-h s}=f(t)$; parameter $D=t_{p} / T$


Fig.12. Test Circuit RBSOA. $V_{C C}=150 \mathrm{~V}$; $-V_{B B}=1-5 \mathrm{~V}$;
$L_{C}=1.5 \mathrm{mH} ; V_{C L}=1450 \mathrm{~V} ; L_{B}=0.3-2 \mu \mathrm{H}$; $C_{F B}=0.5-8 n F ; I_{B(\text { end })}=0.55-1.1 \mathrm{~A}$


Fig.13. Reverse bias safe operating area. $T_{j} \leq T_{j \text { max }}$


Fig.14. $I_{\text {csat }}$ during normal running vs. frequency of operation for optimum performance

## MECHANICAL DATA



Fig.15. SOT199; The seating plane is electrically isolated from all terminals.

## Notes

1. Refer to mounting instructions for F-pack envelopes.
2. Epoxy meets UL94 V0 at 1/8".

## Silicon Diffused Power Transistor

## DEFINITIONS

| Data sheet status |  |
| :--- | :--- |
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one <br> or more of the limiting values may cause permanent damage to the device. These are stress ratings only and <br> operation of the device at these or at any other conditions above those given in the Characteristics sections of <br> this specification is not implied. Exposure to limiting values for extended periods may affect device reliability. |
| Application information | Where application information is given, it is advisory and does not form part of the specification. |
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[^0]:    1 Turn-off current.

[^1]:    2 Measured with half sine-wave voltage (curve tracer).

